Form 1449 (Modified)
Information

Information Disclosure Statement By Applicant

(Use Several Sheets if Necessary)

Attorney Docket No: SUNMP016

Applicant:

KINZHALIN, A., et al.

Filing Date: June 14, 2001 U.S. 09/881,791 CE VED Group 1997 Control 2 2004 2644

**U.S. Patent Documents** 

			<u> </u>				
Examiner Initial	No.	Patent No.	Date	Patentee	Class	Sub- class	Filing Date
HIIIII		r aterit 140.	Date	Tateritee	Class	Class	Date
	Α						<u> </u>
·	В			· · · · · · · · · · · · · · · · · · ·		<u> </u>	
	С						
	D						
	Ε						
	F						
	G						
	Н						
	Ī						
	J						
	K						

Foreign Patent or Published Foreign Patent Application

Examiner		Document	Publication	Country or		Sub-	Trans	lation
Initial	No.	No.	Date	Patent Office	Class	class	Yes	No
	L							
	М	,						
	N							
	0							
,	Р							

## **Other Documents**

Examiner					
Initial	No.	Author, Title, Date, Place (e.g. Journal) of Publication			
Tiw.	R	J. DE RAEVE AND S. MCCARRON: "Automated Test Generation Technology" ADL PROJECT REPORT, 'Online! 1997, pages 1-36, XP002251367 The Opengroup Website Retrieved from the Internet:  URL:http://adl.opengroup.org/documents/Archive/adl10rep.pdf 'retrieved on 2003-08-14! page 2, column 1, line 10  Page 7 –page 13			
7.0.	S	HIROYUKI SEKI ET AL: "A METHOD FOR TRANSLATING NATURAL LANGUAGE PROGRAM SPECIFICATIONS INTO ALGEBRAIC SPECIFICATIONS"  SYSTEMS & COMPUTERS IN JAPAN, SCRIPTA TECHNICA JOURNALS. NEW YORK, US, vol. 23, no. 11, 1992, pages 1-16, XP000380833 ISSN: 0882-1666 page 1, column 1, line 1 –page 5, column 2, line 1			
Examiner	Ì	as a Date Considered 12.10, 2004			

Examiner: Initial citation considered Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.